AP20 Rec'd PCT/PTO 05 JUL 2006

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No.

National Phase Entry of PCT/KR2005/000015

Applicant

Joon-Young AHN

Filed

Herewith

TC/A.U.

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Examiner

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Docket No.

3329-114

Customer No.

6449

Confirmation No.

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450

Sirs:

In compliance with applicants duty of disclosure under 37 C.F.R. § 1.56, enclosed is a copy of the International Search Report in the corresponding international application. The relevance of the references is noted in the International Search Report. We understand that the references have been forwarded by the International Bureau, and are available to the Examiner, but if the Examiner needs copies of any of the references, the Examiner is requested to advise counsel accordingly.

In the event that any fees are due with this paper, please charge our Deposit Account No. 02-2135.

Respectfully submitted,

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RBM/wlg Enclosures

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				Complete if Known		
				Application Number	New 1974 Application	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Filing Date	Filed Herewith	
			N I	First Named Inventor	AHN, Joon-Young	
				Group Art Unit		
				Examiner Name		
				Confirmation No.		
Sheet	1	of	1	Attorney Docket Number	3329-114	

			FOR	REIGN PATI	ENT DOCUMENTS		
Examiner Initials*	Cite No.1	Office ³ Code	Foreign Patent Docur	Ment Kind ⁵ (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	די
	1	JP	54-038882	А	KEIICHI, Isotani	05-24-1979	T
	2	JP	02-107167	Α	TOSHIO, Kagami et al.	04-19-1990	Ī
	3	wo	95/019916	А	BOURJALA et al.	07-27-1995	
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code. ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.